# Application/Control No. O9/879,335 Examiner Yennhu B Huynh Applicant(s)/Patent Under Reexamination AGARWAL ET AL. Art Unit Page 1 of 1

# Notice of References Cited

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,843,830	12-1998	Graettinger et al.	438/396
х	В	US-5,608,249	03-1997	Gonzalez, Fernando	257/306
Х	С	US-6,165,833	12-2000	Parekh et al.	438/240
Х	D	US-6,251,720 B1	06-2001	Thakur et al.	438/240
х	E	US-5,699,291	12-1997	Tsunemine, Yoshikazu	365/149
	F	US-			
	G	US-			
	Н	US-			
_	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
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# NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	х						

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